
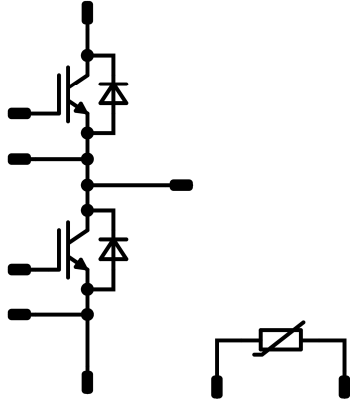




Vincotech

MiniSkiip®DUAL 2	1200 V / 150 A
<div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Features</p> <ul style="list-style-type: none"> Half-Bridge topology Trench IGBT and CAL diode chip technology Integrated NTC sensor Solderless spring contact mounting system </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Target applications</p> <ul style="list-style-type: none"> Charging Stations Industrial Drives Solar Inverters UPS Welding & Cutting </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Types</p> <ul style="list-style-type: none"> 80-M2122PA150SC-K708F40 </div>	<div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">MiniSkiip® 2 housing</p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Schematic</p>  </div>

Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Half-Bridge Switch				
Collector-emitter voltage	V_{CES}		1200	V
Collector current	I_C		150	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	450	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	453	W
Gate-emitter voltage	V_{GES}		±20	V
Short circuit ratings	t_{SC}	$V_{GE} = 15\text{ V}$ $V_{CE} = 800\text{ V}$ $T_j = 150\text{ °C}$	10	µs
Maximum junction temperature	T_{jmax}		175	°C



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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Half-Bridge Diode				
Peak repetitive reverse voltage	V_{RRM}		1200	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	139	A
Surge (non-repetitive) forward current	I_{FSM}	50 Hz Single Half Sine Wave $t_p = 10\text{ ms}$ $T_j = 150\text{ °C}$	860	A
Surge current capability	I^2t		3700	A ² s
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	291	W
Maximum junction temperature	T_{jmax}		175	°C

Module Properties

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{jop}		-40...(T _{jmax} - 25)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC Test Voltage* $t_p = 2\text{ s}$	5500	V
		AC Voltage $t_p = 1\text{ min}$	2500	V
Creepage distance		With std lid For more informations see handling instructions	6,3	mm
Clearance		With std lid For more informations see handling instructions	6,3	mm
Comparative Tracking Index	CTI		> 200	

*100 % tested in production



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Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Half-Bridge Switch

Static

Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{CE}$			0,0052	25	5,2	5,8	6,4	V
Collector-emitter saturation voltage	V_{CEsat}		15		150	25 125 150	1,58	1,83 2,12 2,19	2,07	V
Collector-emitter cut-off current	I_{CES}		0	1200		25			2	μA
Gate-emitter leakage current	I_{GES}		20	0		25			240	nA
Internal gate resistance	r_g							5		Ω
Input capacitance	C_{ies}	$f = 1$ Mhz	0	25		25		8600		pF
Reverse transfer capacitance	C_{res}							320		

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	$\lambda_{paste} = 2,5$ W/mK (HPTP)						0,21		K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$					25 125 150		169 180 182		ns	
Rise time	t_r	$R_{gon} = 2$ Ω $R_{goff} = 2$ Ω				25 125 150		31 35 38			
Turn-off delay time	$t_{d(off)}$					25 125 150		285 355 377			
Fall time	t_f		±15	600	150	25 125 150		56 130 159			
Turn-on energy (per pulse)*	E_{on}	$Q_{t-FWD} = 9,4$ μC $Q_{t-FWD} = 19,5$ μC $Q_{t-FWD} = 23,3$ μC				25 125 150		9,06 13,97 15,83			mWs
Turn-off energy (per pulse)*	E_{off}					25 125 150		8,77 13,54 15,40			

* $L_s = 12$ nH



Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		
Half-Bridge Diode										
Static										
Forward voltage	V_F			150	25 125 150		2,22 2,30 2,23	2,49		V
Reverse leakage current	I_R		1200		25 150			240 28000		μA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	$\lambda_{paste} = 2,5$ W/mK (HPTP)					0,33			K/W
Dynamic										
Peak recovery current	I_{RRM}				25 125 150		133 156 168			A
Reverse recovery time	t_{rr}				25 125 150		212 391 429			ns
Recovered charge	Q_r	$di/dt = 5861$ A/μs $di/dt = 4745$ A/μs $di/dt = 4340$ A/μs	±15	600	150	25 125 150	9,37 19,55 23,33			μC
Reverse recovered energy	E_{rec}				25 125 150		3,25 7,11 8,45			mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$				25 125 150		5536 3331 2909			A/μs
Thermistor										
Rated resistance	R				25		5			kΩ
Deviation of R_{100}	$\Delta_{R/R}$	$R_{100} = 493$ Ω			100	-5		+5		%
Power dissipation	P				25		245			mW
Power dissipation constant					25		1,4			mW/K
B-value	$B_{(25/50)}$	Tol. ±2 %			25		3375			K
B-value	$B_{(25/100)}$	Tol. ±2 %			25		3437			K
Vincotech NTC Reference									K	

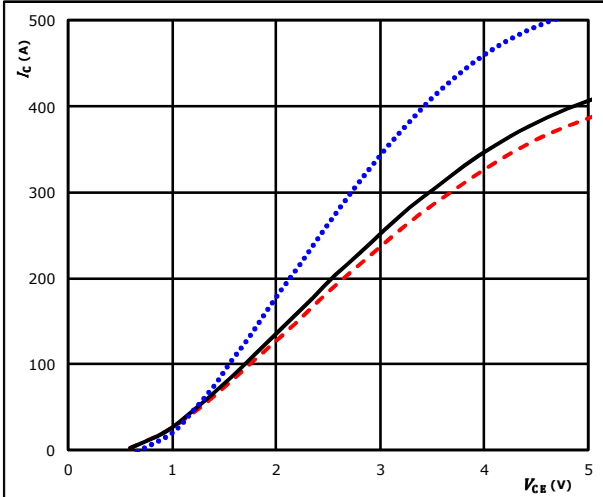


Half-Bridge Switch Characteristics

figure 1. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

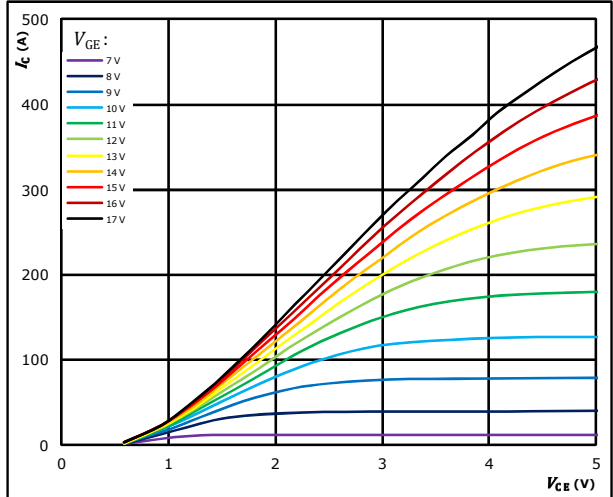


$t_p = 250 \mu s$ $T_j: 25 \text{ }^\circ C$
 $V_{GE} = 15 \text{ V}$ $T_j: 125 \text{ }^\circ C$ ———
 $T_j: 150 \text{ }^\circ C$ - - - -

figure 2. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

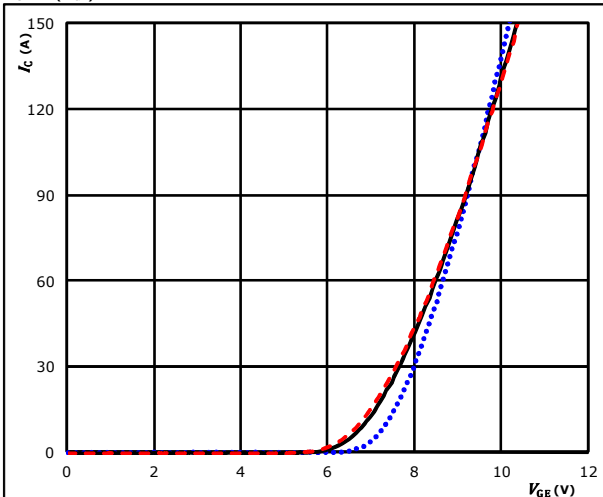


$t_p = 250 \mu s$
 $T_j = 150 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. IGBT

Typical transfer characteristics

$$I_C = f(V_{GE})$$

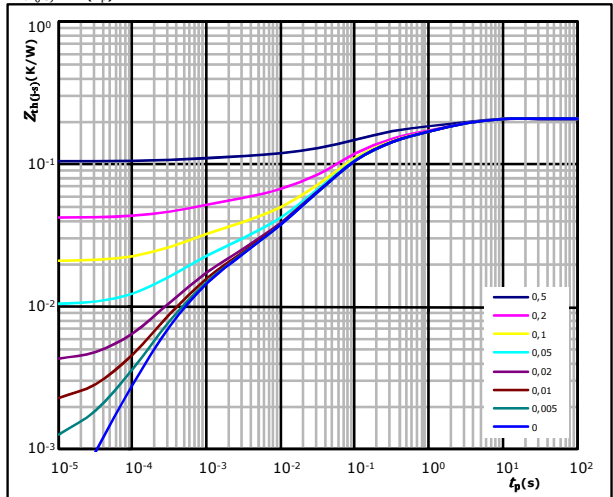


$t_p = 100 \mu s$ $T_j: 25 \text{ }^\circ C$
 $V_{CE} = 10 \text{ V}$ $T_j: 125 \text{ }^\circ C$ ———
 $T_j: 150 \text{ }^\circ C$ - - - -

figure 4. IGBT

Transient thermal impedance as function of pulse duration

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 0,21 \text{ K/W}$
 IGBT thermal model values

R (K/W)	τ (s)
5,76E-02	2,91E+00
4,18E-02	3,82E-01
8,02E-02	8,51E-02
1,35E-02	1,20E-02
9,50E-03	1,62E-03
7,18E-03	4,17E-04

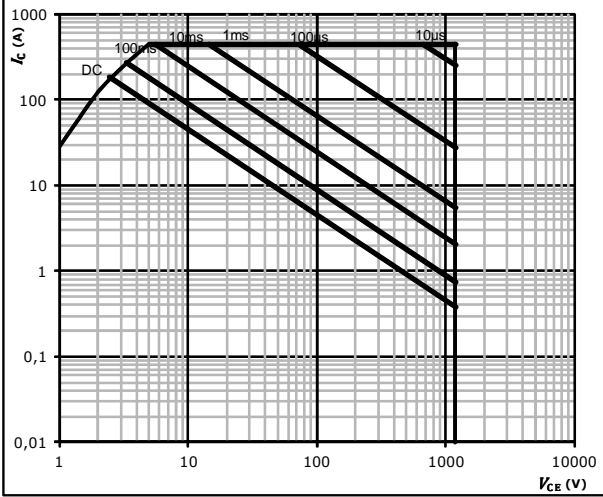


Half-Bridge Switch Characteristics

figure 6. IGBT

Safe operating area

$$I_C = f(V_{CE})$$



- $D =$ single pulse
- $T_s =$ 80 °C
- $V_{GE} =$ ±15 V
- $T_j =$ T_{jmax}

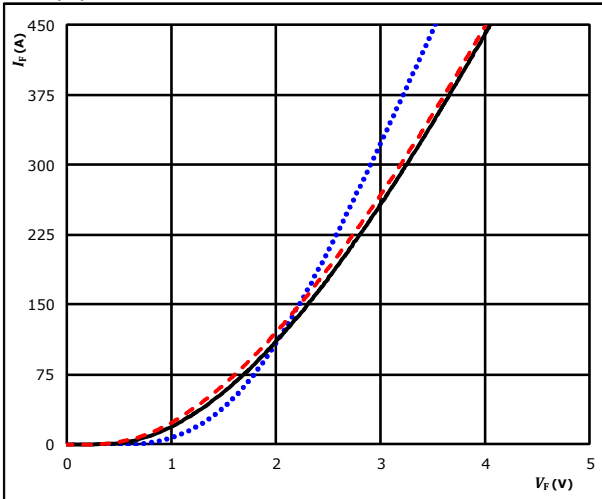


Half-Bridge Diode Characteristics

figure 1. FWD

Typical forward characteristics

$$I_F = f(V_F)$$

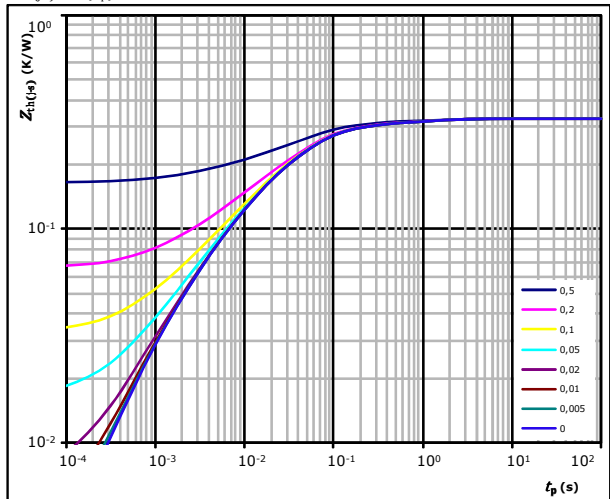


$t_p = 250 \mu s$
 T_j : 25 °C
 125 °C ———
 150 °C - - - -

figure 2. FWD

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 0,33 \text{ K/W}$
 FWD thermal model values

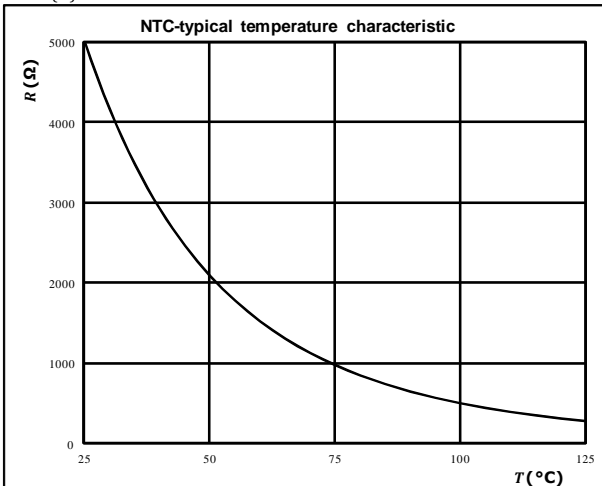
R (K/W)	τ (s)
2,08E-02	2,80E-01
5,00E-02	3,25E-02
1,60E-01	8,01E-03
7,22E-02	1,53E-03
2,11E-02	2,84E-04
3,02E-03	1,60E-04

Thermistor Characteristics

figure 1. Thermistor

Typical NTC characteristic
as a function of temperature

$$R = f(T)$$

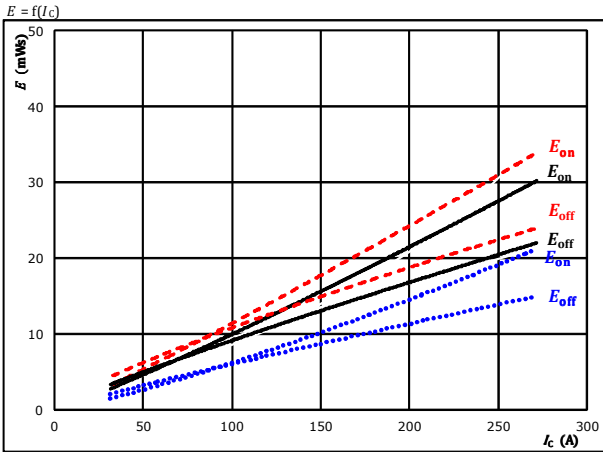




Half-Bridge Switching Characteristics

figure 1. IGBT

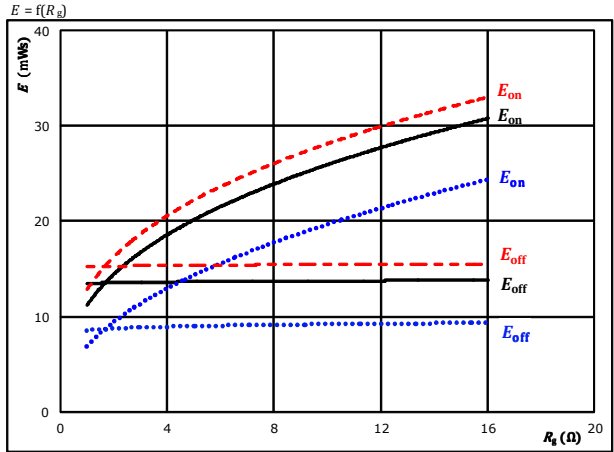
Typical switching energy losses as a function of collector current



With an inductive load at
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω
 $R_{goff} = 2$ Ω
 $T_j: 25$ °C (dotted), 125 °C (solid), 150 °C (dashed)

figure 2. IGBT

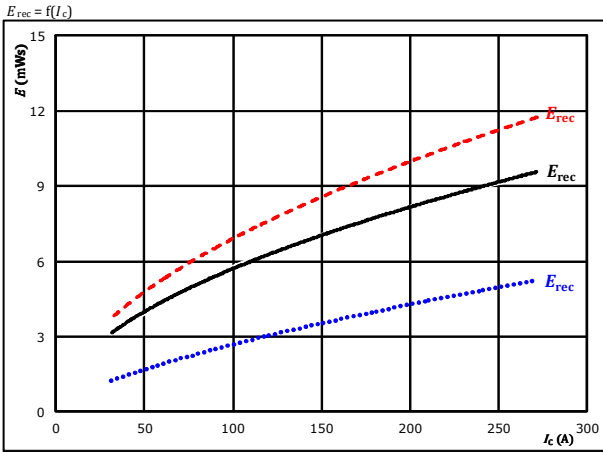
Typical switching energy losses as a function of gate resistor



With an inductive load at
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 150$ A
 $T_j: 25$ °C (dotted), 125 °C (solid), 150 °C (dashed)

figure 3. FWD

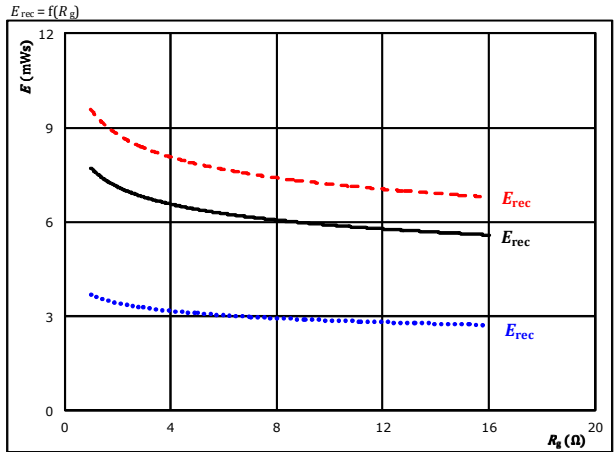
Typical reverse recovered energy loss as a function of collector current



With an inductive load at
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω
 $T_j: 25$ °C (dotted), 125 °C (solid), 150 °C (dashed)

figure 4. FWD

Typical reverse recovered energy loss as a function of gate resistor



With an inductive load at
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 150$ A
 $T_j: 25$ °C (dotted), 125 °C (solid), 150 °C (dashed)

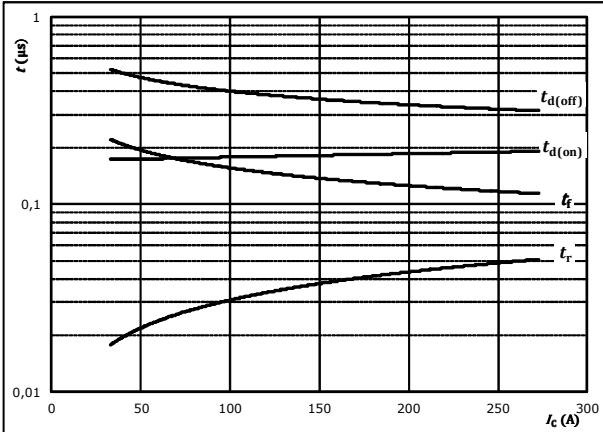


Half-Bridge Switching Characteristics

figure 5. IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



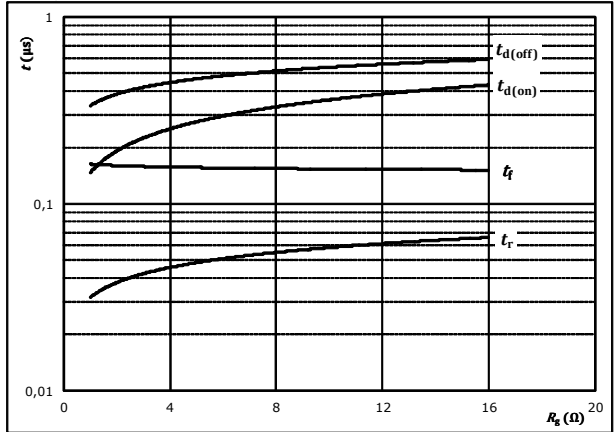
With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	600	V
$V_{GE} =$	±15	V
$R_{gon} =$	2	Ω
$R_{goff} =$	2	Ω

figure 6. IGBT

Typical switching times as a function of gate resistor

$$t = f(R_g)$$



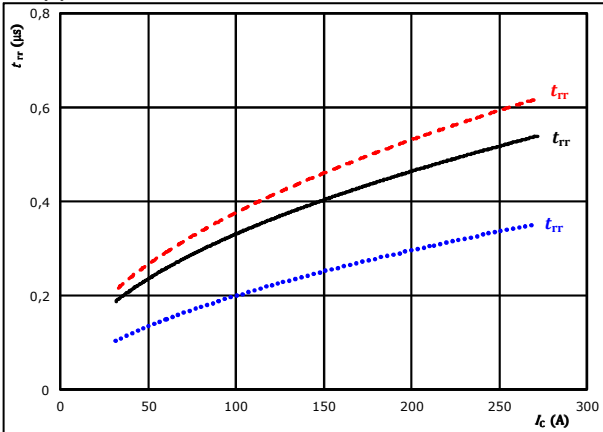
With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	600	V
$V_{GE} =$	±15	V
$I_C =$	150	A

figure 7. FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$

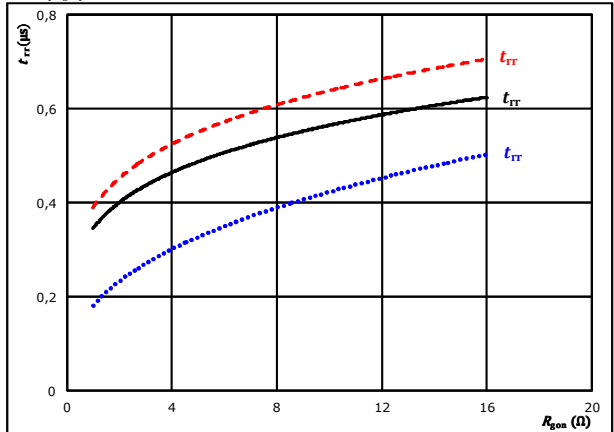


At	$V_{CE} =$	600	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$R_{gon} =$	2	Ω		150 °C	-----

figure 8. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At	$V_{CE} =$	600	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$I_C =$	150	A		150 °C	-----

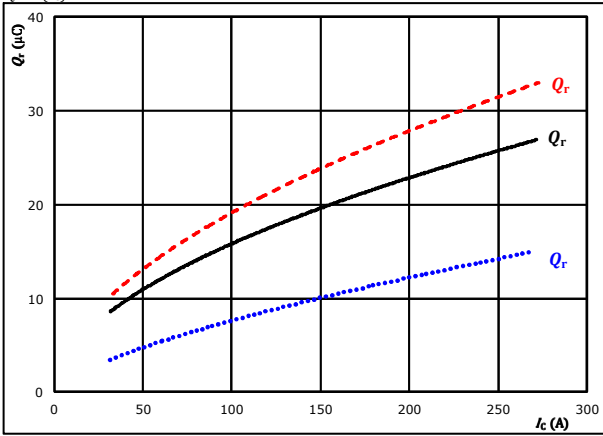


Half-Bridge Switching Characteristics

figure 9. FWD

Typical recovered charge as a function of collector current

$$Q_r = f(I_c)$$

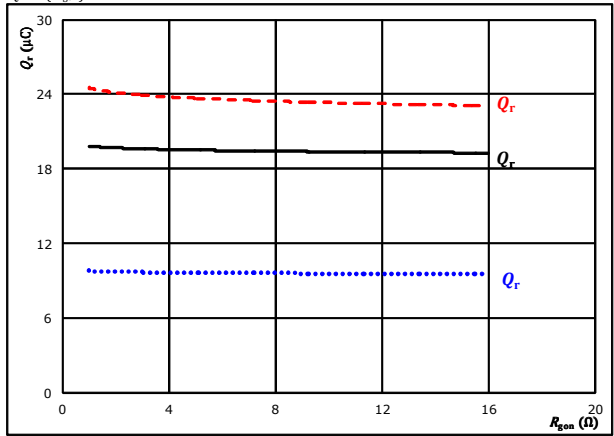


At $V_{CE} = 600$ V $T_j = 25$ °C $V_{GE} = \pm 15$ V $T_j = 125$ °C $R_{gpn} = 2$ Ω $T_j = 150$ °C

figure 10. FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$$Q_r = f(R_{gpn})$$

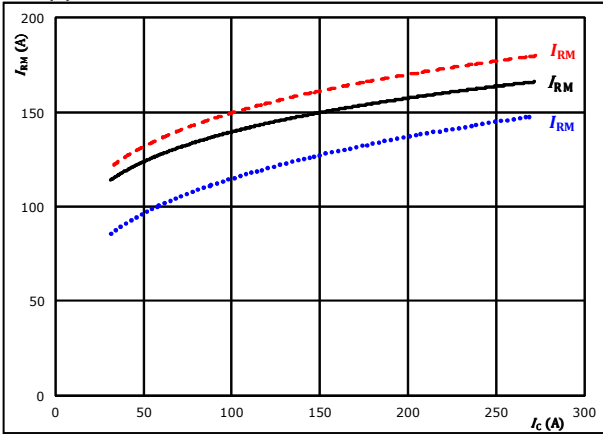


At $V_{CE} = 600$ V $T_j = 25$ °C $V_{GE} = \pm 15$ V $T_j = 125$ °C $I_c = 150$ A $T_j = 150$ °C

figure 11. FWD

Typical peak reverse recovery current current as a function of collector current

$$I_{RM} = f(I_c)$$

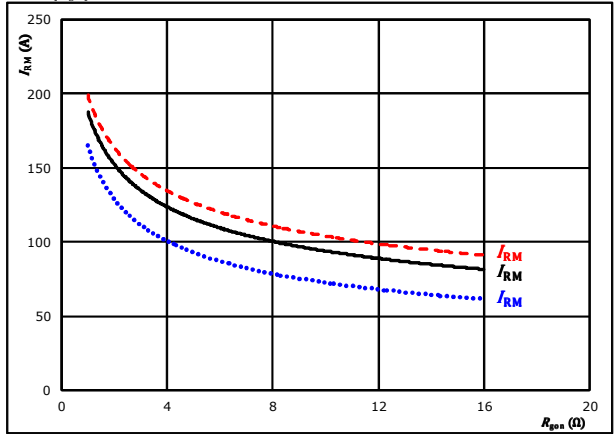


At $V_{CE} = 600$ V $T_j = 25$ °C $V_{GE} = \pm 15$ V $T_j = 125$ °C $R_{gpn} = 2$ Ω $T_j = 150$ °C

figure 12. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RM} = f(R_{gpn})$$



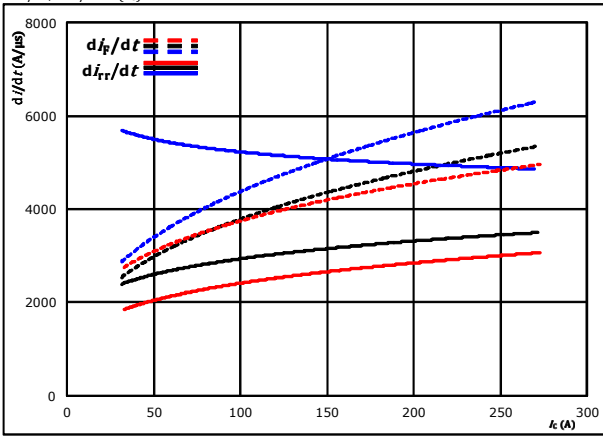
At $V_{CE} = 600$ V $T_j = 25$ °C $V_{GE} = \pm 15$ V $T_j = 125$ °C $I_c = 150$ A $T_j = 150$ °C



Half-Bridge Switching Characteristics

figure 13. FWD

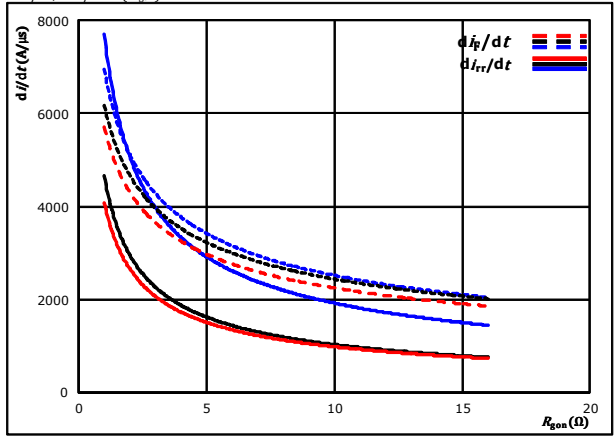
Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_f/dt, di_{rr}/dt = f(I_c)$



At $V_{CE} = 600$ V $T_j = 25$ °C
 $V_{GE} = \pm 15$ V $T_j = 125$ °C
 $R_{g(on)} = 2$ Ω $T_j = 150$ °C

figure 14. FWD

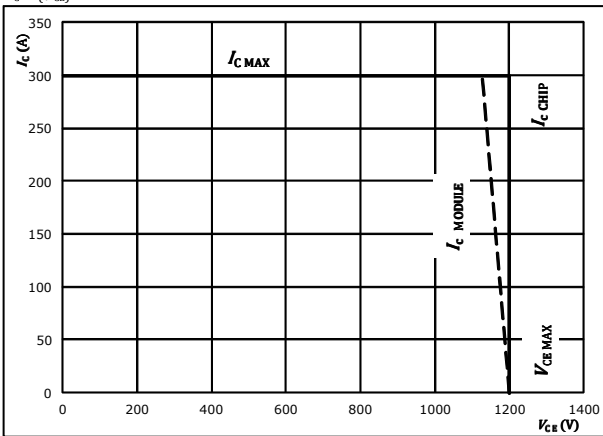
Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_{g(on)})$



At $V_{CE} = 600$ V $T_j = 25$ °C
 $V_{GE} = \pm 15$ V $T_j = 125$ °C
 $I_c = 150$ A $T_j = 150$ °C

figure 15. IGBT

Reverse bias safe operating area
 $I_c = f(V_{CE})$



At $T_j = 125$ °C
 $R_{g(on)} = 2$ Ω
 $R_{g(off)} = 2$ Ω



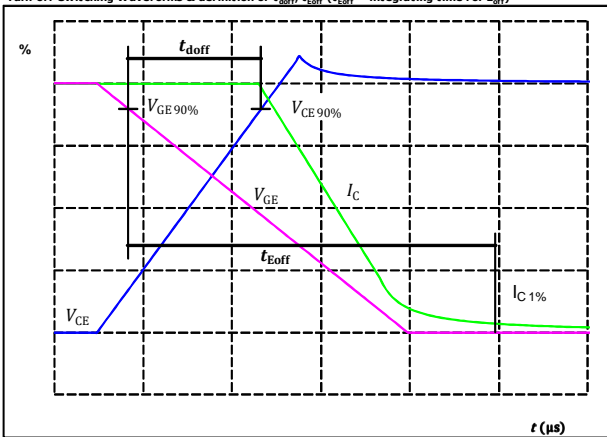
Half-Bridge Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	2 Ω
R_{goff}	=	2 Ω

figure 1. IGBT

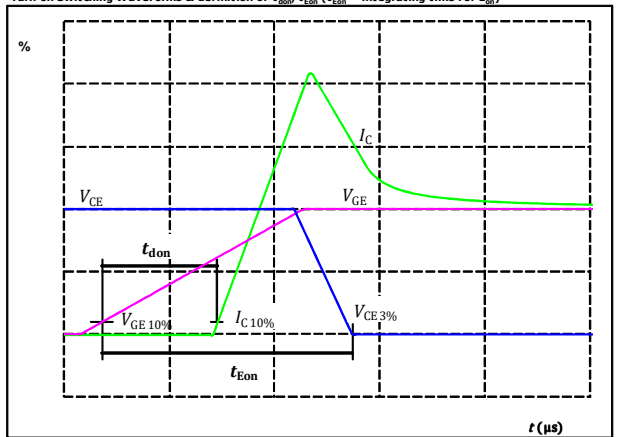
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	600	V
$I_C(100\%) =$	150	A
$t_{doff} =$	355	ns

figure 2. IGBT

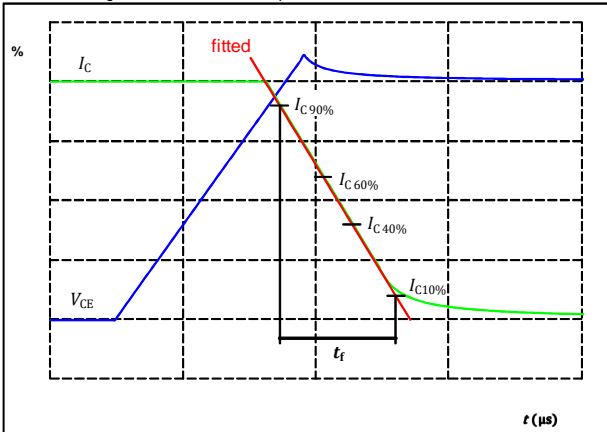
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	600	V
$I_C(100\%) =$	150	A
$t_{don} =$	180	ns

figure 3. IGBT

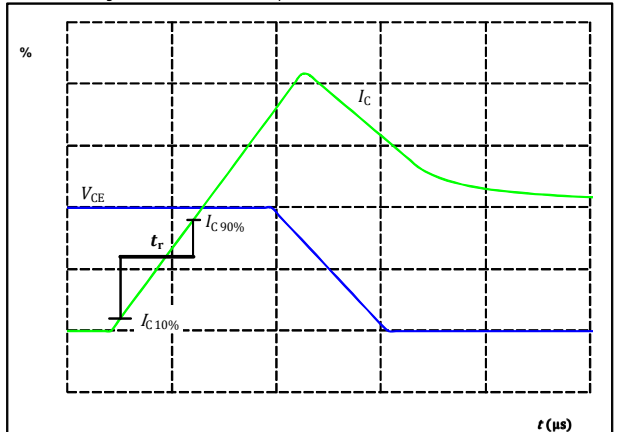
Turn-off Switching Waveforms & definition of t_r



$V_C(100\%) =$	600	V
$I_C(100\%) =$	150	A
$t_r =$	130	ns

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r



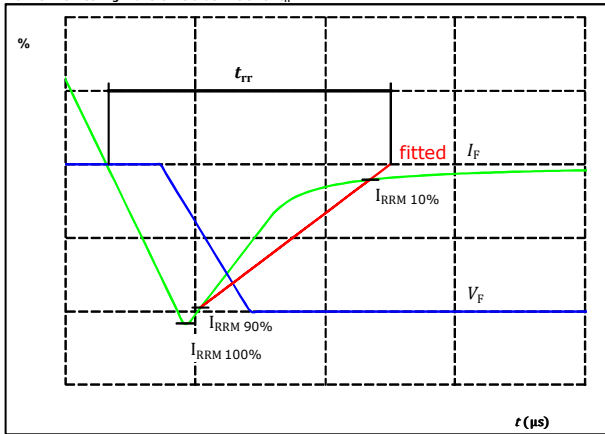
$V_C(100\%) =$	600	V
$I_C(100\%) =$	150	A
$t_r =$	35	ns



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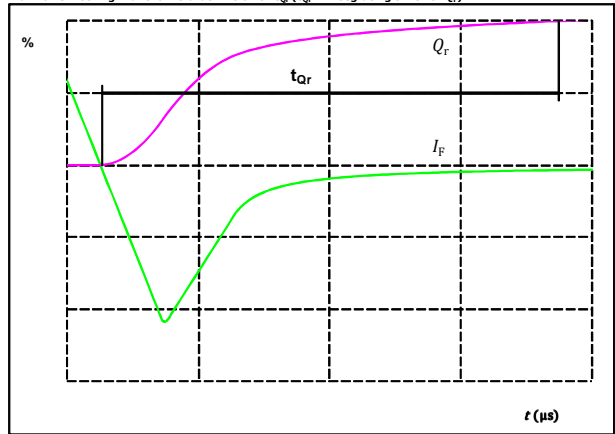
Half-Bridge Switching Characteristics

figure 5. FWD
Turn-off Switching Waveforms & definition of t_{rr}



$V_F(100\%) =$	600	V
$I_F(100\%) =$	150	A
$I_{RRM}(100\%) =$	156	A
$t_{rr} =$	391	ns

figure 6. FWD
Turn-on Switching Waveforms & definition of t_{qr} ($t_{qr} =$ integrating time for Q_r)



$I_F(100\%) =$	150	A
$Q_r(100\%) =$	19,55	μC



Vincotech

Ordering Code & Marking								
Version			Ordering Code					
With std lid (6.5mm height) + no thermal grease			80-M2122PA150SC-K708F40-/0A/					
With thin lid (2.8mm height) + no thermal grease			80-M2122PA150SC-K708F40-/0B/					
With std lid (6.5mm height) + thermal grease (0,8 W/mK, P12, silicone-based)			80-M2122PA150SC-K708F40-/1A/					
With thin lid (2.8mm height) + thermal grease (0,8 W/mK, P12, silicone-based)			80-M2122PA150SC-K708F40-/1B/					
With std lid (6.5mm height) + thermal grease (2,5 W/mK, TG20032, silicone-free)			80-M2122PA150SC-K708F40-/4A/					
With thin lid (2.8mm height) + thermal grease (2,5 W/mK, TG20032, silicone-free)			80-M2122PA150SC-K708F40-/4B/					
With std lid (6.5mm height) + thermal grease (2,5 W/mK, HPTP, silicone-based)			80-M2122PA150SC-K708F40-/5A/					
With thin lid (2.8mm height) + thermal grease (2,5 W/mK, HPTP, silicone-based)			80-M2122PA150SC-K708F40-/5B/					
NN-NNNNNNNNNNNN TTTTWWWWY UL VIN LLLLL SSSS		Text	Name		Date code	UL & VIN	Lot	Serial
			NN-NNNNNNNNNNNN-TTTTWW		WWYY	UL VIN	LLLLL	SSSS
			Type&Ver	Lot number	Serial	Date code		
Datamatrix			TTTTTWW	LLLLL	SSSS	WWYY		

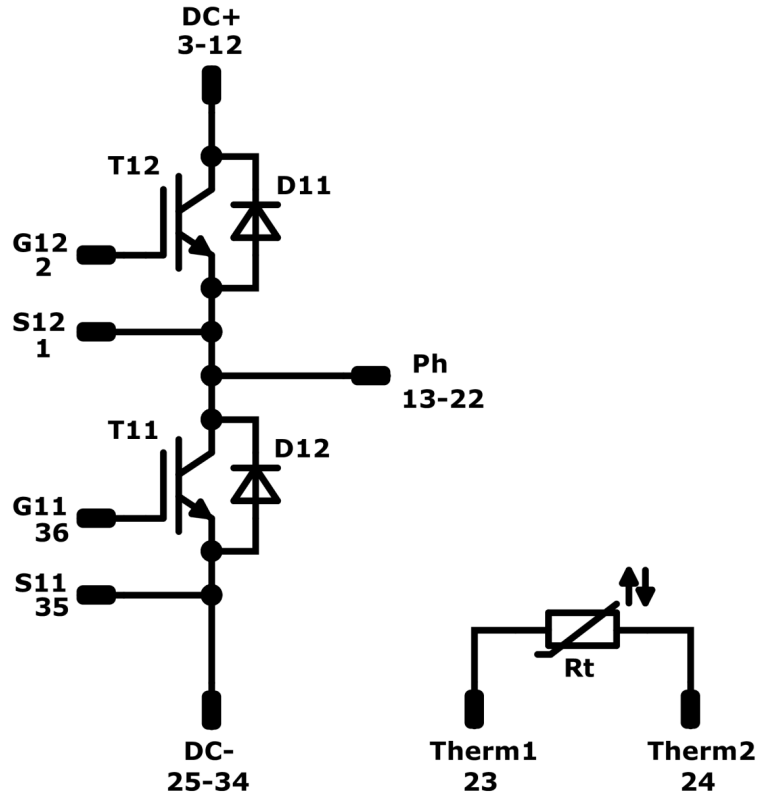
PCB pad table				Outline	
Pin	X	Y	Function		
1	-7,6	21,9	S12		
2	4,7	21,9	G12		
3	18,6	21,8	DC+		
4	18,6	18,6	DC+		
5	18,6	15,4	DC+		
6	18,6	12,2	DC+		
7	18,6	9	DC+		
8	22,5	21,8	DC+		
9	22,5	18,6	DC+		
10	22,5	15,4	DC+		
11	22,5	12,2	DC+		
12	22,5	9	DC+		
13	-22,5	7,8	Ph		
14	-22,5	4,6	Ph		
15	-22,5	1,4	Ph		
16	-22,5	-1,8	Ph		
17	-22,5	-5	Ph		
18	-18,6	7,8	Ph		
19	-18,6	4,6	Ph		
20	-18,6	1,4	Ph		
21	-18,6	-1,8	Ph		
22	-18,6	-5	Ph		
23	-6,8	1,6	Therm1		
24	-6,8	-1,6	Therm2		
25	18,6	-9	DC-		
26	18,6	-12,2	DC-		
27	18,6	-15,4	DC-		
28	18,6	-18,6	DC-		
29	18,6	-21,8	DC-		
30	22,5	-9	DC-		
31	22,5	-12,2	DC-		
32	22,5	-15,4	DC-		
33	22,5	-18,6	DC-		
34	22,5	-21,8	DC-		
35	4,6	-18,7	S11		
36	1,7	-21,9	G11		

Pad positions refers to center point. For more informations on pad design please see package data



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Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11 , T12	IGBT	1200 V	150 A	Half-Bridge Switch	
D11 , D12	FWD	1200 V	150 A	Half-Bridge Diode	
Rt	NTC			Thermistor	




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Packaging instruction			
Standard packaging quantity (SPQ) 72	>SPQ	Standard	<SPQ Sample

Handling instruction
Handling instructions for MiniSkiiP® 2 packages see vincotech.com website.

Package data
Package data for MiniSkiiP® 2 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
80-M2122PA150SC-K708F40-D2-14	30 May. 2018	Thermal interface changed to HPTP	All

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.